

Search Notes



Application/Control No.

10/607,698

Examiner

Frederick J. Parker

Applicant(s)/Patent under Reexamination

FREE ET AL.

Art Unit

1762

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|---------|----------|
| 427 | 96.1 | ↑ | ↑ |
| ↓ | 97.1 | ↑ | ↑ |
| ↓ | 97.3 | ↑ | ↑ |
| ↓ | 118 | ↑ | ↑ |
| ↓ | 154 | ↑ | ↑ |
| ↓ | 272 | 9/26/06 | JP |
| ↓ | 240 | ↑ | ↑ |
| ↓ | 446 | ↑ | ↑ |
| ↓ | 420 | ↑ | ↑ |
| ↓ | 430.1 | ↓ | ↓ |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|---------------------|---------|----------|
| 427 | 96.1 97.1 | ↑ | ↑ |
| ↓ | 97.3 118 | ↑ | ↑ |
| ↓ | 154 272 240 | 9/26/06 | JP |
| ↓ | 446 420 430.1 | ↓ | ↓ |

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|---------------------------------|---------|------|
| EAST update strategy within. | 9/26/06 | JP |
| EAST, EDAU inventor name search | 9/26/06 | JP |
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